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TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

2SK1062

High Speed Switching Applications Analog Switching Applications Interface Applications

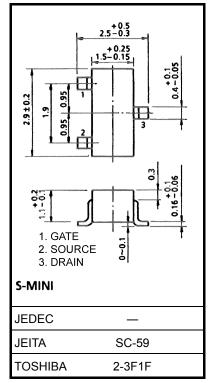
- Excellent switching time: ton = 14 ns (typ.)
- High forward transfer admittance: $|Y_{fs}| = 100 \text{ ms} (\text{min})$

@I_D = 50 mA

- Low on resistance: $RDS(ON) = 0.6 \Omega$ (typ.) @ ID = 50 mA
- Enhancement-mode
- Complementary to 2SJ168

Absolute Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit | |
|---|-------|------------------|---------|------|--|
| Drain-source voltage | | V _{DS} | 60 | V | |
| Gate-source voltage | | V _{GSS} | ±20 | V | |
| Drain current | DC | I _D | 200 | mA | |
| | Pulse | I _{DP} | 800 | | |
| Drain power dissipation (Ta = 25° C) | | PD | 200 | mW | |
| Channel temperature | | T _{ch} | 150 | °C | |
| Storage temperature range | | T _{stg} | -55~150 | °C | |

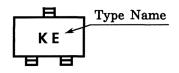


Weight: 0.012 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Marking



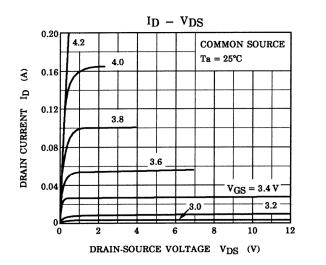
Unit: mm

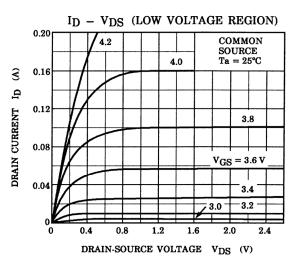
Electrical Characteristics (Ta = 25°C)

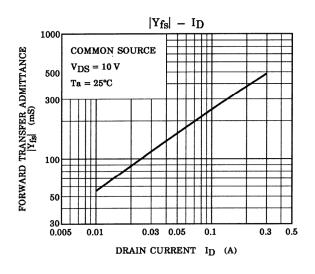
| Characteristics | | Symbol | Test Condition | Min | Тур. | Max | Unit |
|------------------------------|----------------|----------------------|--|-----|------|------|------|
| Gate leakage current | | I _{GSS} | $V_{GS}=\pm 10~V,~V_{DS}=0$ | _ | _ | ±100 | nA |
| Drain cut-off current | | I _{DSS} | $V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0$ | | | 10 | μA |
| Drain-source brea | akdown voltage | V (BR) DSS | $I_D = 1 \text{ mA}, V_{GS} = 0$ | 60 | | | V |
| Gate threshold vo | oltage | V _{th} | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$ | 2 | | 3.5 | V |
| Forward transfer | admittance | Y _{fs} | $V_{DS} = 10 \text{ V}, \text{ I}_{D} = 50 \text{ mA}$ | 100 | | | mS |
| Drain-source ON | resistance | R _{DS (ON)} | $I_D = 50$ mA, $V_{GS} = 10$ V | _ | 0.6 | 1.0 | Ω |
| Drain-source ON voltage | | V _{DS (ON)} | $I_D = 50$ mA, $V_{GS} = 10$ V | _ | 30 | 50 | mV |
| Input capacitance | 9 | C _{iss} | $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$ | _ | 55 | 65 | pF |
| Reverse transfer capacitance | | C _{rss} | $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$ | _ | 13 | 18 | pF |
| Output capacitance | | C _{oss} | $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$ | _ | 40 | 50 | pF |
| Switching time | Rise time | tr | $I_{D} = 100 \text{ mA}$ $I_{D} = 100 \text{ mA}$ $I_{D} = 100 \text{ mA}$ V_{N} $V_{D} = 10 \mu \text{S}$ $V_{DD} = 30 \text{ V}$ | — | 8 | _ | ns |
| | Turn-on time | t _{on} | | _ | 14 | _ | |
| | Fall time | t _f | | | 35 | _ | |
| | Turn-off Time | t _{off} | V_{IN} : t_r , $t_f < 5 \text{ ns}$ D.U \leq 1% (Z _{out} = 50 Ω) | | 75 | | |

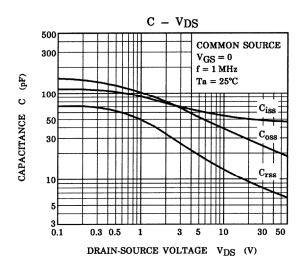
Note: This transistor is the electrostatic sensitive device. Please handle with caution.

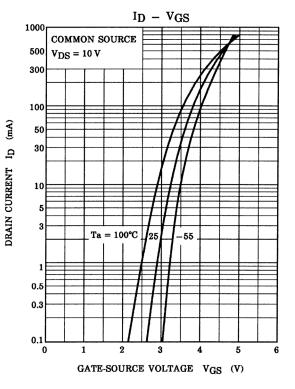
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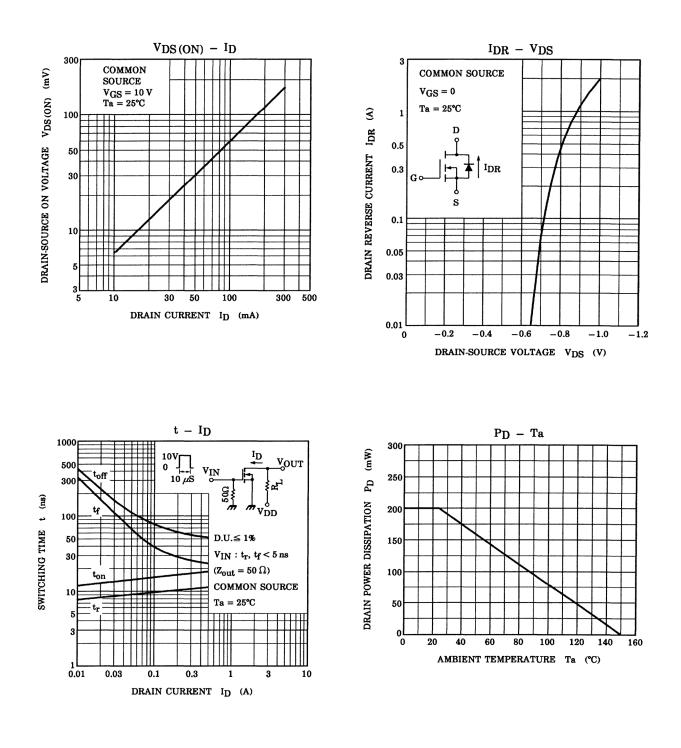








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20070701-EN GENERAL

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